

16 A three-quadrant triacs insulated, high commutation, high temperature

Rev. 02 — 11 March 2008

**Product data sheet** 

#### **Product profile** 1.

### 1.1 General description

Passivated, new generation, high commutation triacs in an internally insulated TO-220 plastic package.

#### 1.2 Features

- Very high commutation performance
- Isolated mounting base
- High operating junction temperature
- High immunity to dV/dt
- 2500 V RMS isolation voltage

### 1.3 Applications

- Heating and cooking appliances
- cleaners
- Solid state relays

- Non-linear rectifier-fed motor loads
- High power motor control e.g. vacuum
   Electronic thermostats for heating and cooling loads

## 1.4 Quick reference data

- $V_{DRM} \le 600 \text{ V (BTA416Y-600B/C)}$
- $V_{DRM} \le 800 \text{ V (BTA416Y-800B/C)}$
- $I_{TSM} \le 160 \text{ A (t = 20 ms)}$
- $I_{GT} \le 50 \text{ mA (BTA416Y series B)}$
- I<sub>GT</sub>  $\leq$  35 mA (BTA416Y series C)
- $I_{T(RMS)} \le 16 A$



# 2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	main terminal 1 (T1)		N.1
2	main terminal 2 (T2)	mb	T2—T1
3	gate (G)	/ O \	`G sym051
mb	mounting base; isolated		
		SOT78D (TO-220)	

# 3. Ordering information

Table 2. Ordering information

Type number	Package					
	Name	Description	Version			
BTA416Y-600B	TO-220	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220	SOT78D			
BTA416Y-600C						
BTA416Y-800B						
BTA416Y-800C						

# 4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage	BTA416Y-600B; BTA416Y-600C	<u>[1]</u> _	600	V
		BTA416Y-800B; BTA416Y-800C	-	800	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; $T_{mb} \le 108 ^{\circ}\text{C}$ ; see Figure 4 and 5	-	16	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 20 ms	-	160	Α
		t = 16.7 ms	-	176	Α
l <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms	-	128	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_{TM} = 20 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$	-	100	A/μs
$I_{GM}$	peak gate current		-	4	Α
$P_{GM}$	peak gate power		-	5	W

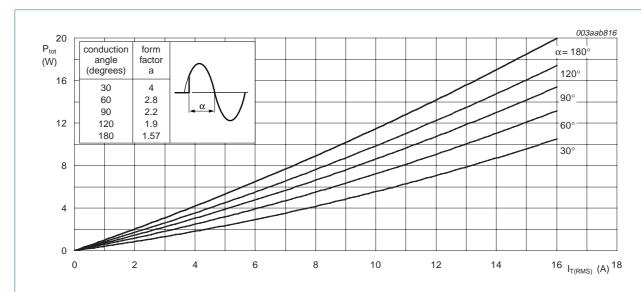
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Table 3. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

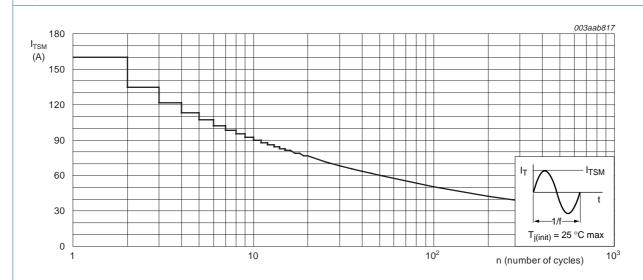
Symbol	Parameter	Conditions	Min	Max	Unit
$P_{G(AV)}$	average gate power	over any 20 ms period	-	1	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
T <sub>j</sub>	junction temperature		-	150	°C

[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/μs.



 $\alpha$  = conduction angle

Fig 1. Total power dissipation as a function of RMS on-state current; maximum values



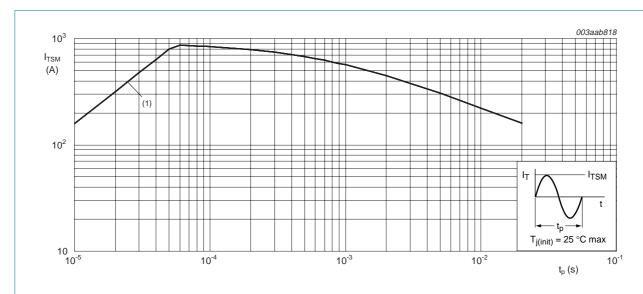
f = 50 Hz

Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum Fig 2. values

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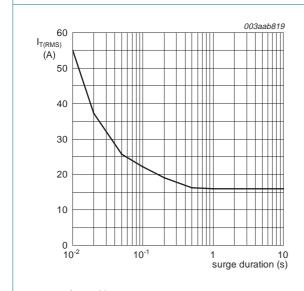
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 $t_p \le 20 \text{ ms}$ 

(1) dl<sub>T</sub>/dt limit

Fig 3. Non-repetitive peak on-state current as a function of pulse duration; maximum values



f = 50 Hz;

T<sub>mb</sub> = 108 °C

Fig 4. RMS on-state current as a function of surge duration; maximum values

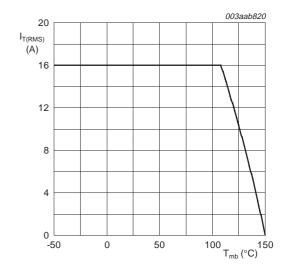
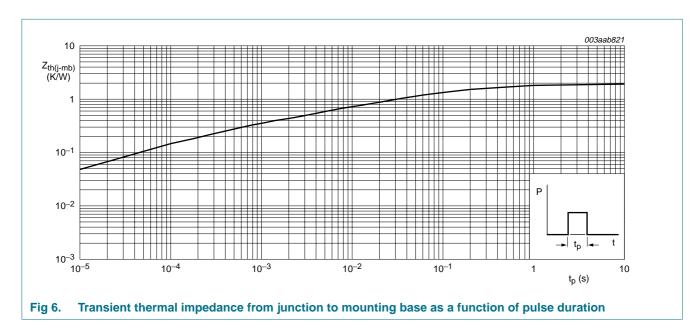


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values

## 5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	full cycle; see Figure 6	-	-	1.9	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	-	60	-	K/W



## 6. Isolation characteristics

#### Table 5. Isolation limiting values and characteristics

 $T_h = 25 \,^{\circ}C$  unless otherwise specified.

**	•					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>isol(RMS)</sub>	RMS isolation voltage	from all three terminals to external heatsink; f = 50 Hz to 60 Hz; sinusoidal waveform; RH ≤ 65 %; clean and dust free	-	-	2500	V
C <sub>isol</sub>	isolation capacitance	from pin 2 to external heatsink; f = 1 MHz	-	10	-	pF

# 7. Static characteristics

Table 6. Static characteristics

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions		BTA416Y-600B BTA416Y-800B			BTA416Y-600C BTA416Y-800C		
			Min	Тур	Max	Min	Тур	Max	
I <sub>GT</sub>	gate trigger	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 8}}{}$	'			'			
	current	T2+ G+	2	-	50	2	-	35	mΑ
		T2+ G-	2	-	50	2	-	35	mA
		T2- G-	2	-	50	2	-	35	mA
I <sub>L</sub> latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 10}}{\text{Figure 10}}$								
		T2+ G+	-	-	60	-	-	50	mA
		T2+ G-	-	-	90	-	-	60	mΑ
		T2- G-	-	-	60	-	-	50	mΑ
I <sub>H</sub>	holding current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 11}{\text{Figure } 11}$	-	-	60	-	-	35	mΑ
$V_{T}$	on-state voltage	I <sub>T</sub> = 20 A; see <u>Figure 9</u>	-	1.2	1.5	-	1.2	1.5	V
$V_{GT}$	V <sub>GT</sub> gate trigger	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 7}}{}$	-	0.7	1.5	-	0.7	1.5	V
voltage	voltage	$V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 150 ^{\circ}\text{C}$	0.25	0.4	-	0.25	0.4	-	V
$I_D$	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-	0.1	0.5	-	0.1	0.5	mΑ
		$V_D = V_{DRM(max)}$ ; $T_j = 150  ^{\circ}C$	-	0.4	2	-	0.4	2	mA

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# 8. Dynamic characteristics

Table 7. Dynamic characteristics

Symbol	Parameter	Conditions	BTA416Y-600B BTA416Y-800B			BTA416Y-600C BTA416Y-800C			Unit
			Min	Тур	Max	Min	Тур	Max	
dV <sub>D</sub> /dt	V <sub>D</sub> /dt rate of rise of off-state	$V_{DM} = 0.67 \times V_{DRM(max)}$ ; $T_j = 125  ^{\circ}\text{C}$ ; exponential waveform; gate open circuit	1000	-	-	500	-	-	V/μs
voltage	$V_{DM} = 0.67 \times V_{DRM(max)}$ ; $T_j = 150  ^{\circ}\text{C}$ ; exponential waveform; gate open circuit	600	-	-	300	-	-	V/μs	
dI <sub>com</sub> /dt	of without snubber; gate open circuit	$V_{DM} = 400 \text{ V}; T_j = 125 ^{\circ}\text{C}; I_{T(RMS)} = 16 \text{ A};$ without snubber; gate open circuit	15	-	-	10	-	-	A/ms
		$V_{DM} = 400 \text{ V}; T_j = 150 ^{\circ}\text{C}; I_{T(RMS)} = 16 \text{ A};$ without snubber; gate open circuit	6	-	-	4	-	-	A/ms
t <sub>gt</sub>	gate-controlle d turn-on time	$I_{TM} = 20 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A};$ $dI_G/dt = 5 \text{ A}/\mu \text{s}$	-	2	-	-	2	-	μs

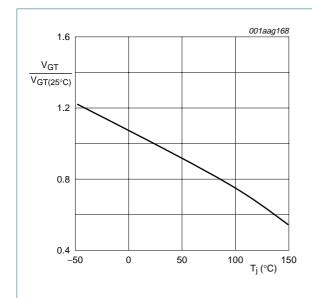
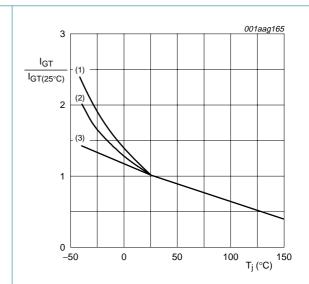
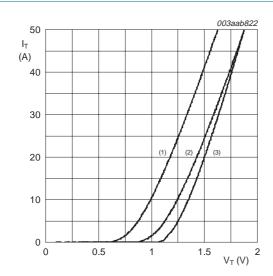


Fig 7. Normalized gate trigger voltage as a function of junction temperature



- (1) T2-G-
- (2) T2+ G-
- (3) T2+ G+

Fig 8. Normalized gate trigger current as a function of junction temperature



 $V_0 = 1.086 \text{ V}$ 

 $R_s = 0.017 \Omega$ 

- (1)  $T_j = 150 \,^{\circ}\text{C}$ ; typical values
- (2)  $T_i = 150 \,^{\circ}C$ ; maximum values
- (3)  $T_i = 25$  °C; maximum values

Fig 9. On-state current as a function of on-state voltage

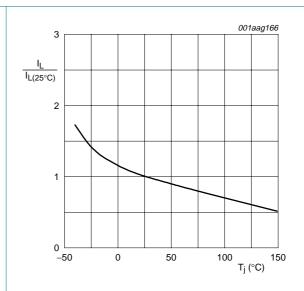


Fig 10. Normalized latching current as a function of junction temperature

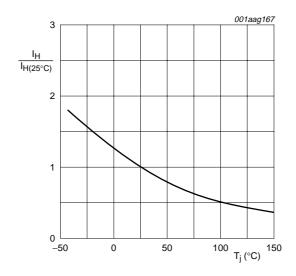


Fig 11. Normalized holding current as a function of junction temperature

# 9. Package outline

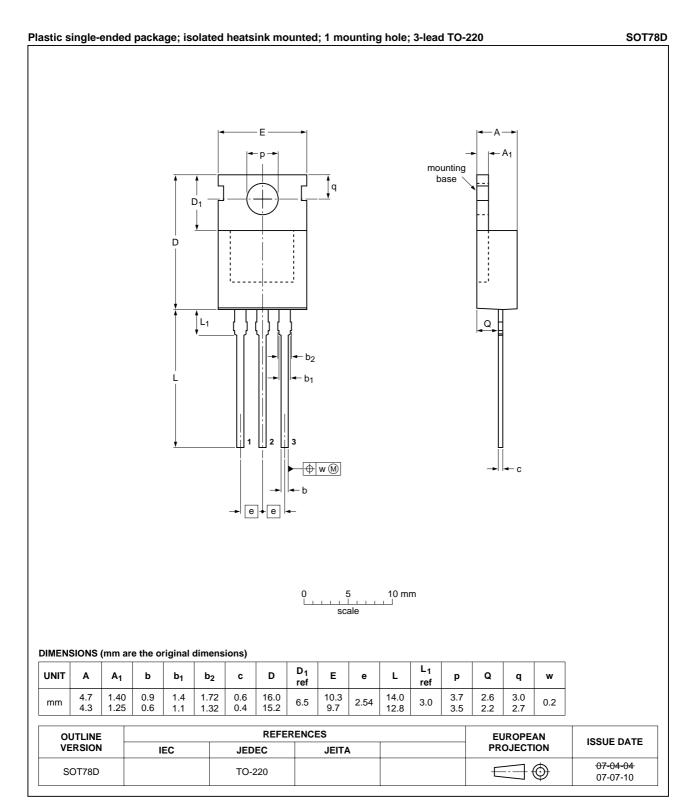


Fig 12. Package outline SOT78D (TO-220)

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# 10. Revision history

### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BTA416Y_SER_B_C_2	20080311	Product data sheet	-	BTA416Y_SER_B_C_1		
Modifications:	Modifications:  • Table 3 "Limiting values" uprated values for I <sub>GM</sub> and P <sub>G(AV)</sub> • Table 3 "Limiting values" updated I²t condition symbol					
BTA416Y_SER_B_C_1	20071003	Product data sheet	-	-		

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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- [2] The term 'short data sheet' is explained in section "Definitions"
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